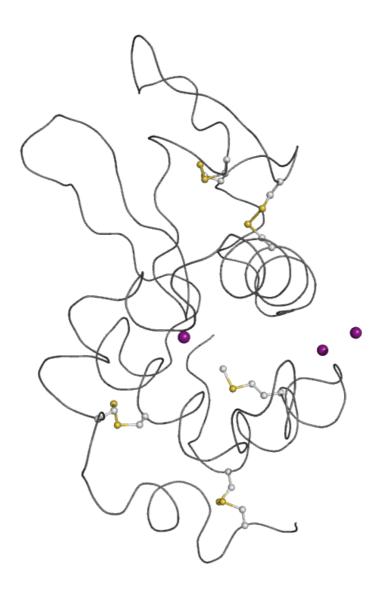
A tutorial for learning and teaching macromolecular crystallography – version 2010

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Experiment 6: Single Isomorphous Replacement with Anomalous Scattering (SIRAS) on tetragonal lysozyme

Lysozyme is a 129 amino acid enzyme that dissolves bacterial cell walls by catalyzing the hydrolysis of 1,4-β-linkages between N-acetylmuramic acid and N-acetyl-D-glucosamine residues in the peptidoglycan layer and between N-acetyl-D-glucosamine residues in chitodextrins. It is abundant in a number of secreted fluids, such as tears, saliva and mucus. Lysozyme is also present in cytoplasmic granules of the polymorphonuclear neutrophils (Voet *et al.*, 2006). Large amounts of lysozyme can also be found for instance in egg whites. The crystal structure of hen egg-white lysozyme (HEWL) based on crystals belonging to the tetragonal space group P4₃2₁2, was the first enzyme structure published (Blake *et al.*, 1965). Over the years, HEWL has been crystallized in many different crystal forms (for an overview see Brinkmann *et al.*, 2006) and has become a standard object for methods developments but also for teaching purposes.

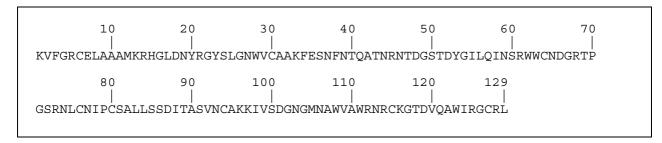


Figure 1: Amino acid sequence of hen egg-white lysozyme

Isomorphous Replacement is the traditional method of phase determination in Macromolecular Crystallography. In this method the structure factor amplitudes of a native protein crystal (F_P) are compared to the amplitudes of a protein crystal, which has been derivatized by co-crystallization or soaking with a heavy atom containing compound (F_{PH}). Under the presumption that both crystals are isomorphous, the differences ($|F_{PH} - F_P|$) can be used to identify the positions of the heavy atoms. The resulting heavy atom structure (F_H) can then be used as reference structure for phase determination. The process of phase determination is shown graphically in the form of the so-called Harker construction (F_{I}) and F_{I} are known (these are the measured structure factor amplitudes of the native and the derivative data sets) and if F_H is known as vector (this means that the heavy atom structure is known) the phase can be determined. In the case of SIR (F_{I}), however, the phase determination yields two values (phase ambiguity), while in the case of MIR (not shown) and SIRAS (F_{I}) an unambiguous phase determination can be performed.

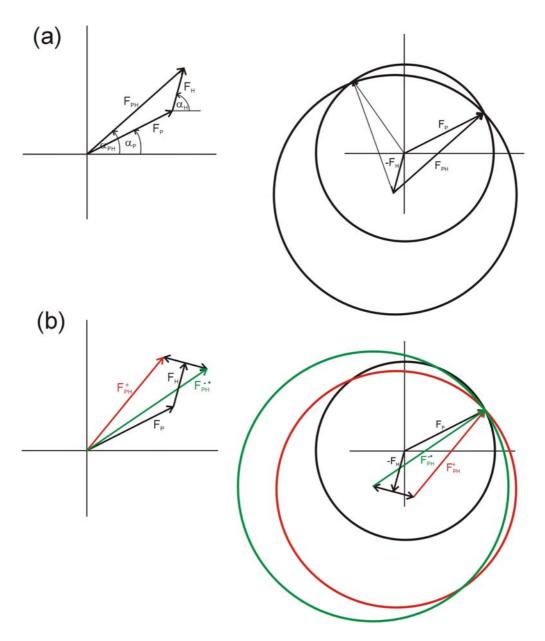


Figure 2: Harker construction. (a) SIR-case (b) SIRAS -case

1 Crystallisation and Derivatisation

Chemicals: Hen egg-white lysozyme (M \approx 14600 g/mol, Fluka cat. no. 62970)

 CH_3COONa (M = 82.03 g/mol, Sigma cat. no. S2889)

 $CH_3COOH (M = 60.0 \text{ g/mol}, \text{ Sigma cat. no. } 537020)$

NaCl (M = 58.44 g/mol, Sigma cat. no. S7653)

Ethylene glycol (M = 62.07 g/mol, Merck, cat. no. 109621)

 $KAuCl_4$ (M = 377.88 g/mol, Aldrich, cat. no. 33,454-5)

Milli-Q water

Tetragonal crystals of HEWL were grown as described by Weiss *et al.* (2000) by mixing 4 μ l of protein solution (30 mg/ml in water) and 4 μ l of reservoir solution containing 50 mM Na acetate pH 4.5 and 5% (w/v) NaCl and equilibrating the drop against the reservoir. The crystals belong to space group P4₃2₁2 (space group number 96) and exhibit the usual unit-cell parameters of a = 78.8 Å and c = 37.2 Å (Figure 3). They appeared within few days after setting up the experiment. Prior to flash cooling to 100 K, they were transferred into a solution containing 25% (v/v) ethylene glycol, 10% (w/v) NaCl and 100 mM Na acetate pH 4.5. They typically diffracted X-rays to a resolution better than 1.6 Å.

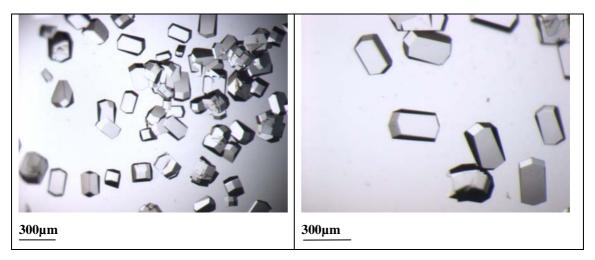


Figure 3: Tetragonal HEWL crystals.

A 10 mM solution of KAuCl₄ in reservoir solution was freshly prepared and one crystal was soaked in this solution for 1 minute (Sun *et al.*, 2002). This crystal was then also cryo-protected in a solution containing 25% (v/v) ethylene glycol, 10% (w/v) NaCl and 100 mM Na acetate pH 4.5. The diffraction properties of such derivatized crystals are significantly worse than the ones for the native crystals but still very much acceptable (Figure 4).

2 Data Collection

Native and derivative X-ray diffraction data have been collected at the tunable beam line BL14.2 at the BESSY-II synchrotron in Berlin-Adlershof. The beam line is equipped with a MARMosaic CCD detector (225mm) from the company MARRESEARCH (Norderstedt, Germany) and a MARdtb goniostat (MARRESEARCH, Norderstedt, Germany).

The relevant data collection parameters are given below:

	<u>Native</u>	<u>Derivative</u>	
wavelength	1.00 Å	1.00 Å	
detector distance:	180 mm	180 mm	
oscillation range/image:	1.0°	1.0°	
no. of images:	180	180	
exposure time/image:	2.5 sec	5.0 sec	
path to images:	/exp6/data/native/	/exp6/data/derive/	
image names:	exp6_lyso_siras_native_###.img		
		exp6_lyso_siras_deriv_###.img	

For the derivative data set, the data collection was interrupted after image 113 due to an injection. Afterwards, the data collection was continued with the same exposure time but a beam attenuation using 0.19 mm Al in order to compensate for the increased beam intensity.

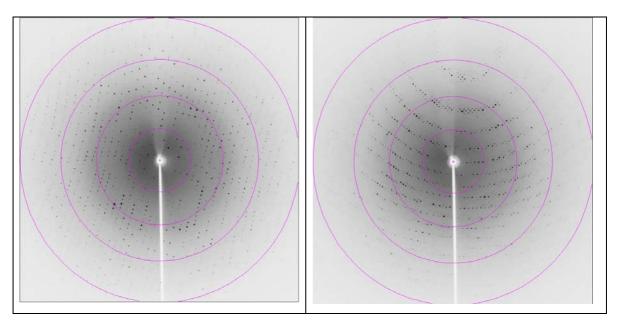


Figure 4: Diffraction images of native and derivatized tetragonal lysozyme crystals. The resolution rings shown are at 7.2, 3.6, 2.4 and 1.8 Å, respectively.

3 Data Processing

The collected diffraction data were indexed, integrated and scaled using the program XDS (Kabsch, 1993, 2010a,b). XDS is simply run by the command *xds*. If a multi-processor machine is available, the command *xds_par* can be used, which calls a parallel version of XDS and consequently runs much faster. XDS needs only one input file, which must be called XDS.INP. No other name is recognized by the program. The file XDS.INP contains all relevant information about the data collection, from beam parameters to detector parameters and crystal parameters (if known) as well as the data collection geometry. In XDS.INP one can also define the steps through which the program should go. This is done by using the parameter JOBS. The following command, which is equivalent to JOBS= ALL would make XDS run through all eight steps XYCORR, INIT, COLSPOT, IDXREF, DEFPIX, XPLAN, INTEGRATE and CORRECT.

JOBS= XYCORR INIT COLSPOT IDXREF DEFPIX XPLAN INTEGRATE CORRECT

In the XYCORR step, tables of spatial correction factors are set up (if required). INIT calculates the gain of the detector and produces an initial background table. COLSPOT identifies strong reflections which are used for indexing. IDXREF performs the actual indexing of the crystal. DEFPIX identifies the regions on the detector surface which are used for measuring intensities, XPLAN helps to devise a data collection strategy, INTEGRATE integrates the reflection intensities of the whole data set and CORRECT scales and merges symmetry-related reflections and multiple measurements. It also prints out data processing statistics. After completing each individual step, a log-file with a name corresponding to the step (STEP-name.LP) is written.

Action 1: edit the supplied file XDS.INP and insert the relevant information about the data collection, namely the data collection wavelength, crystal-to-detector distance, the direct beam coordinates, the total number of images, and rotation increment per image and of course very importantly the path to and the names of the image files. XDS is able to recognize compressed images; therefore it is not necessary to unzip the data before using XDS. The image name given must not include the zipping-format extension (*.img instead of *.img.bz2). Further, XDS has a very limited string length (80) to describe the path to the images. Therefore it may be necessary to create a soft link to the directory containing the images by using the command *In -s* /path/to/images/./images. The path to the images in XDS.INP will then be ./images/. If the space group and cell dimensions are known, the relevant information should be written into XDS.INP, if they are not known just set the parameter **SPACE GROUP NUMBER= 0**.

Action 2: run XDS until the indexing step, with the parameter JOBS set to:

JOBS= XYCORR INIT COLSPOT IDXREF

The output file IDXREF.LP contains the results of the indexing. It needs to be checked carefully whether the indexing is correct, since all subsequent steps assume the correctness of the indexing step. The most relevant parameters to look for are the STANDARD DEVIATION OF SPOT POSITION and the STANDARD DEVIATION OF SPINDLE POSITION. The first one should be in the order of 1 pixel, whereas the second one depends to some extent on the rotation increment per image but also on the mosaicity of the crystal. If it is 0.1° it is very good, if it is 0.5° it might still be ok, if it is larger than 1.0° the indexing has probably not worked. The table with the entries SUBTREE and POPULATION is also very interesting to look at. The first SUBTREE should have by a large margin more entries than all others. Also, the input parameters, such as the crystal-to-detector distance should after refinement not deviate too much from the input values.

The most common problem with the IDXREF step is that it often finishes with the message !!! ERROR !!! INSUFFICIENT PERCENTAGE (<70%) OF INDEXED REFLECTIONS. This means that less than 70% of the reflections that were collected in the COLSPOT step are not indexed, which may happen because of ice rings on the frames, split reflections or simply wrong input parameters. However, if all indicators of correct indexing are fine (see above) and no obvious errors can be identified then this message can be safely ignored and data processing can be continued.

If IDXREF was run with **SPACE_GROUP_NUMBER= 0**, an assumption of the correct Bravais lattice may be made at this stage. As a rule of thumb, choose the lattice of the highest possible symmetry, with a QUALITY OF FIT-value as low as possible (usually < 10). These numbers are printed in IDXREF.LP in the paragraph DETERMINATION OF LATTICE CHARACTER AND **BRAVAIS** LATTICE. Then, re-run the **IDXREF** with step the parameter SPACE GROUP NUMBER corresponding to the assumed Bravais lattice in XDS.INP. Alternatively, it is possible to make no assumption of the Bravais lattice at this point, and to simply continue with data integration. In this case the program will assume that space group determination should not be based on the metric symmetry of the lattice, but should be postponed to the CORRECT step (see below).

Nevertheless, if the true lattice is known, it should yield a good, i.e. low QUALITY OF FIT-number. For tetragonal HEWL, the correct space group is P4₃2₁2 (space group number 96) with unit cell parameters of a=78.7 and c=37.1 Å.

<u>Action 3</u>: After the determination of the Bravais lattice and the cell parameters all images need to be integrated and corrections (radiation damage, absorption, detector etc.) will have to be calculated. This can be done in a further XDS run.

JOBS= DEFPIX XPLAN INTEGRATE CORRECT

The CORRECT step produces a file called CORRECT.LP, which contains the statistics for the complete data set after integration and corrections. For the statistics to be meaningful, the correct Laue symmetry has to be established first. To this end, the CORRECT step compares the statistics in all possible Laue groups. The correct Laue group is the one with the highest symmetry, which at the same time still exhibits an acceptable $R_{r.i.m.}/R_{meas}$. CORRECT writes a file named XDS_ASCII.HKL, which contains the integrated and scaled reflections.

The CORRECT step also performs a refinement of all geometric parameters and the cell dimensions based on all reflections of the data set. These parameters may be more accurate than the ones obtained from the indexing step. Therefore, one may try to use the refined parameters and to re-run the last XDS job. In order to not overwrite the original results, it is advisable to save all current files to a temporary directory. Then, the file GXPARM.XDS should be renamed or copied to XPARM.XDS and XDS be re-run. In case the original results are better, they can be copied back to the original directory.

While XDS will usually identify the correct Laue group, it does not determine the actual space group of the crystal. The decision about the existence of screw axes is left to the user. Indications, which screw axes may be present can be obtained from the table REFLECTIONS OF TYPE H,0,0 0,K,0 0,0,L OR EXPECTED TO BE ABSENT (*) in the file CORRECT.LP. Alternatively, the program POINTLESS (Evans 2005) offers an automatic way of assigning the space group. POINTLESS can be run with the command *pointless XDSIN XDS_ASCII.HKL*. In the output the possible space groups together with their probabilities are given. Some space group ambiguity still remains at this stage, since it is impossible to distinguish between enantiomorphic space groups e.g. P3₁ and P3₂, or P4₁2₁2 and P4₃2₁2 just based on intensities. This ambiguity has to be resolved later during structure solution. The parameter SPACE_GROUP_NUMBER corresponding to the determined space group as well as the cell parameters should be entered into the file XDS.INP for running the next step.

<u>Action 4</u>: Finally, outlier reflections are identified by CORRECT by comparing their intensity to the average intensity in their respective resolution shells. These outliers may be removed, if there is a clear indication and reason for their existence: for example, ice rings often produce very strong reflections at specific d-spacings. The outliers are flagged as 'alien' in the file CORRECT.LP and their removal can simply be achieved by writing the outliers into a file called REMOVE.HKL. By re-running XDS with the command

JOBS= CORRECT

in XDS.INP, these outliers are then disregarded. This last action can be repeated until no more additional outliers are identified. However, the outlier removal has to be handled very carefully because strong reflections may also arise from non-crystallographic symmetry and in particular from the presence of pseudo-translation. A command to identify only the most extreme outliers would be <code>awk '/alien/ { if (strtonum(\$5) > 19) print \$0 }' CORRECT.LP >> REMOVE.HKL</code>. This command will remove outliers only when their Z-score is above 19. Hints to suitable criteria for outlier rejection can be found in the XDSwiki (http://strucbio.biologie.uni-konstanz.de/xdswiki), where this question is treated specifically in the article "Optimization".

Action 5:, The CORRECT step can be followed up by running the scaling program XSCALE, which is part of the XDS program package. This serves three purposes: a) the user may specify the limits of the resolution shells for which statistics should be printed, b) several XDS_ASCII.HKL files may be scaled together and c) correction factors for radiation damage may be applied to the data (see also the article "XSCALE" in the XDSwiki). XSCALE is run by simply typing xscale (or xscale_par to speed up the computation on a multi-processor machine) provided that a file XSCALE. INP defining the input and output files is present. As above in the CORRECT step, outliers may be rejected. XSCALE writes out a *.ahkl file, which can be converted with XDSCONV to be used within the CCP4-suite (Collaborative Computational Project, 1994) or other programs.

Both CORRECT and XSCALE will produce all necessary output for assembling a table with all relevant data processing statistics, which is necessary for a publication.

Table 1: Data processing statistics (in this case from CORRECT.LP)

	Native	Derivative	
Resolution limits [Å]	50.0 - 1.60 (1.70 - 1.60)	50.0 - 1.80 (1.91 - 1.80)	
Space group	P4 ₃ 2 ₁ 2	P4 ₃ 2 ₁ 2	
Unit cell parameters a, c [Å]	78.62, 36.81	78.73, 36.73	
Mosaicity [*]	0.13	0.17	
Total number of reflections	187497	152422	
Unique reflections	28363	20439	
Redundancy	6.6 (3.4)	7.5 (7.1)	
Completeness [%]	97.4 (86.3)	99.5 (97.5)	
I/σ(I)	27.4 (5.2)	15.6 (3.0)	
R _{r.i.m.} / R _{meas} [%]	4.8 (24.6)	9.9 (71.1)	
Wilson B-factor [Å ²]	20.3	28.3	

Action 6: finally, the processed intensity file needs to be converted to certain file formats, which are used by other programs to perform the necessary structure determination steps. This can be achieved using the program XDSCONV, which can simply be run by using the command *xdsconv* provided that a file called XDSCONV.INP is present. XDSCONV.INP just needs to contain information about the name of the input file and about the name and type of the output file. If a CCP4-type file is required, XDSCONV reformats the reflection output file from XSCALE and creates an input file F2MTZ.INP for the final conversion of the reflection file to binary mtz-format, which is the standard format for all CCP4 programs (CCP4, 1994).

OUTPUT_FILE=lyso_siras.hkl CCP4

INPUT_FILE=lyso siras.ahkl

To run the CCP4 programs F2MTZ and CAD, just type the two commands

f2mtz HKLOUT temp.mtz < F2MTZ.INP

and

cad HKLIN1 temp.mtz HKLOUT lyso_siras_ccp4.mtz << eof

LABIN FILE 1 ALL

END

eof

Some CCP4 programs need the intensities of the Bijvoet pairs as input. For those the second parameter on the OUTPUT_FILE= line should be **CCP4_I** instead of **CCP4**. Alternatively, the file XDS_ASCII.HKL can be converted to mtz-format using the CCP4-programs COMBAT or POINTLESS (Evans, 2005) and this mtz-file can be used as an input file for the scaling program SCALA (Evans, 2005) in CCP4. More information on this can be found in the articles "Pointless" and "Scaling with SCALA" in the XDSwiki.

With an R-factor to the native data set of 22% and an anomalous correlation coefficient CC_{anom} of 47% (calculated using the CCP4 program SCALEIT), the derivative data set contains significant isomorphous and anomalous signal, respectively. This is exemplified by the inspection of Patterson maps (Figure 5), which have been calculated based on the isomorphous differences (|FPH| - |FP|) or the anomalous differences (|FPH⁺| - |FPH⁻|) using the program FFT within the CCP4-suite.

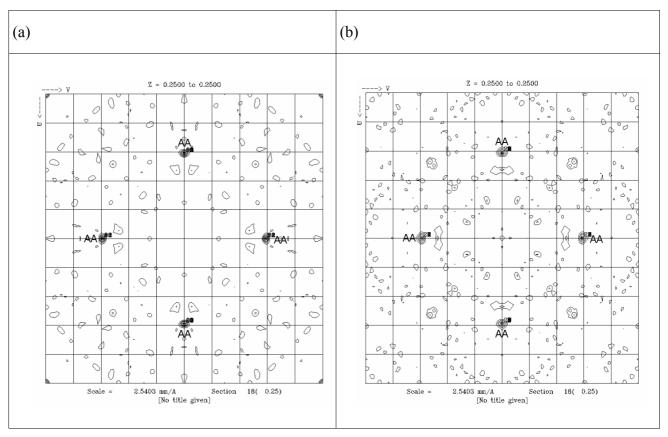


Figure 5: Difference (a) and anomalous difference (b) Patterson map. Shown are the Harker sections w=1/4 in both cases. The peak denoted AA and the corresponding symmetry related peaks are the Harker peaks of the Au site no. 1.

4 Structure Solution

The structure can be solved using the SIRAS-protocol (advanced version) of Auto-Rickshaw, the EMBL-Hamburg automated crystal structure determination platform (Panjikar *et al.*, 2005, 2009). AUTO-RICKSHAW can be accessed from outside EMBL under www.embl-hamburg.de/Auto-Rickshaw/LICENSE (a free registration may be required, please follow the instructions on the web page). In the following the automatically generated summary of AUTO-RICKSHAW is printed together with the results of the structure determination:

The input diffraction data files XDS ASCII.HKL were uploaded and then prepared and converted using programs of the CCP4-suite (CCP4, 1994). ΔF and $||F_{PH}-|| - |F_P||$ -values were calculated using the program SHELXC (Sheldrick et al., 2001, Sheldrick, 2008). Based on an initial analysis of the data, the maximum resolution for substructure determination and initial phase calculation was set to 2.4 A. Three heavy atom sites were found using the program SHELXD (Schneider & Sheldrick, 2002) with correlation coefficients of 35.98% and 23.74% for all and for just the weak reflections, respectively. The correct hand for the substructure was determined using the programs ABS (Hao, 2004) and SHELXE (Sheldrick, 2002). Initial phases were calculated after density modification using the program SHELXE. A poly-Ala model was automatically built using the program SHELXE and ARP/wARP (Perrakis et al., 1999; Morris et al., 2004). This resulted in a model, which was 95% complete already. To complete the model and to enhance the phases the MRSAD module of AUTO-RICKSHAW (Panjikar et al., 2009) was used. This resulted in a model consisting of 127 residues, of which 125 were docked in the amino acid sequence. This model was refined using REFMAC5 and further modified using COOT (Emsley, 2004). The final R-factor for the model was 21.8% and the free R-factor was 27% (see directory exp6/struct ref/).

Table 2: List of heavy atom peaks found using SHELXD corresponding to the three Au sites.

Rank	X	y	Z	Occupancy
1	67.093	11.725	0.909	1.00
2	69.980	9.972	-4.114	0.69
3	67.297	11.323	-9.203	0.33

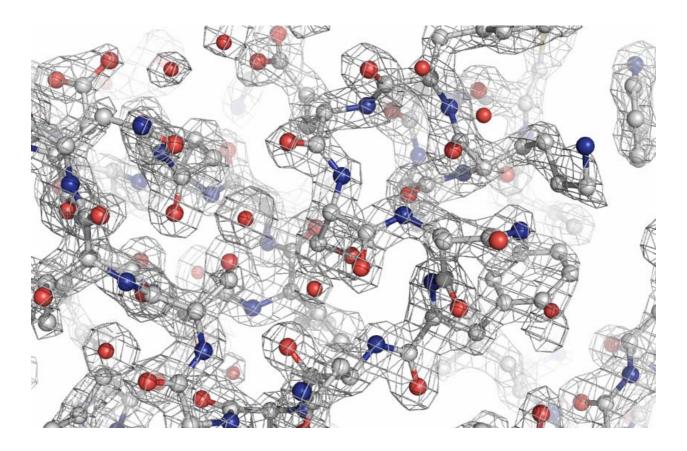


Figure 6: Experimental electron density map after density modification contoured at 1.5σ. The superimposed model is the one, which was automatically build by SHELXE and ARP/wARP using the phase information derived from the anomalous signal of the three Au sites.



Figure 7: Refined structure of the KAuCl₄-derivative of tetragonal HEWL presented as a thin tube (in gray). Also shown are the Met and Cys side chains of HEWL (as ball-and-stick) and the bound gold atoms (in purple). Superimposed on the structure is the anomalous difference Fourier electron density map contoured at 4.0 σ. The first Au-atom is located 3.6 Å from the SD-atom of Met105 and 4.4 Å from the NE-atom of Trp108. The second and the third Au atoms are located on both sides of the side chain of His15. One is located 2.1 Å from the NE2-atom while the other is found 2.0 Å from the ND1-atom of His15.

5 References

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